

# DATA SHEET

### N-Channel Silicon MOSFET **CPH5612**—General-Purpose Switching Device **Applications**

#### **Features**

- · Low ON-resistance.
- Ultrahigh-speed switching.
- 2.5V drive.
- Composite type with 2 MOSFETs contained in a single package, facilitaing-density mounting.

#### **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		100	V
Gate-to-Source Voltage	VGSS		±10	V
Drain Current (DC)	ID		1	А
Drain Current (Pulse)	IDP	PW≤10µs, duty cycle≤1%	4	А
Allowable Power Dissipation	PD	Mounted on a ceramic board (600mm <sup>2</sup> X0.8mm) 1unit	0.9	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

#### Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Linit
			min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=1mA, VGS=0	100			V
Zero-Gate Voltage Drain Current	IDSS	V <sub>DS</sub> =100V, V <sub>GS</sub> =0			1	μΑ
Gate-to-Source Leakage Current	IGSS	VGS=±8V, VDS=0			±10	μA
Cutoff Voltage	VGS(off)	V <sub>DS</sub> =10V, I <sub>D</sub> =1mA	0.4		1.3	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> =10V, I <sub>D</sub> =500mA	1.8	2.6		S
Static Drain-to-Source On-State Resistance	RDS(on)1	ID=500mA, VGS=4V		430	570	mΩ
	R <sub>DS</sub> (on)2	ID=500mA, VGS=2.5V		450	650	mΩ
Input Capacitance	Ciss	VDS=20V, f=1MHz		350		pF
Output Capacitance	Coss	VDS=20V, f=1MHz		20		pF
Reverse Transfer Capacitance	Crss	V <sub>DS</sub> =20V, f=1MHz		12		pF
Turn-ON Delay Time	t <sub>d</sub> (on)	See specified Test Circuit.		15		ns
Rise Time	tr	See specified Test Circuit.		11		ns
Turn-OFF Delay Time	t <sub>d</sub> (off)	See specified Test Circuit.		54		ns
Fall Time	tf	See specified Test Circuit.		30		ns
Marking : FS				Co	ntinued on	next page

- Any and all SANYO products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your SANYO representative nearest you before using any SANYO products described or contained herein in such applications.
- SANYO assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all SANYO products described or contained herein.

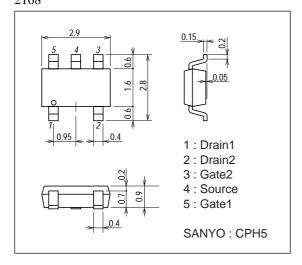
SANYO Electric Co., Ltd. Semiconductor Company TOKYO OFFICE Tokyo Bldg., 1-10, 1 Chome, Ueno, Taito-ku, TOKYO, 110-8534 JAPAN

#### C查响他们的600%共有

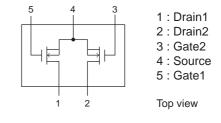
Parameter	Symbol	Conditions	Ratings			Unit
	Symbol		min	typ	max	
Total Gate Charge	Qg	VDS=50V, VGS=4V, ID=1A		4.4		nC
Gate-to-Source Charge	Qgs	V <sub>DS</sub> =50V, V <sub>GS</sub> =4V, I <sub>D</sub> =1A		1.2		nC
Gate-to-Drain "Miller" Charge	Qgd	VDS=50V, VGS=4V, ID=1A		0.8		nC
Diode Forward Voltage	VSD	IS=1A, VGS=0		0.82	1.2	V

#### **Package Dimensions**

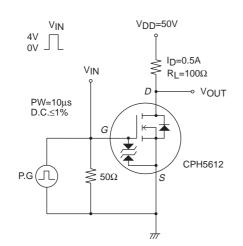
unit : mm 2168

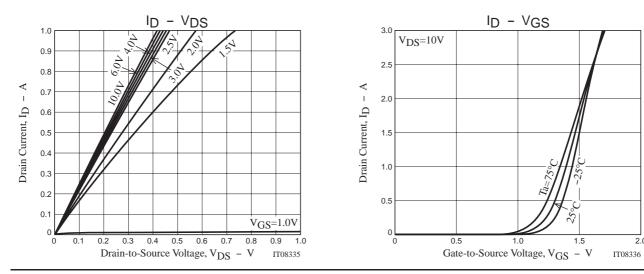


#### **Electrical Connection**

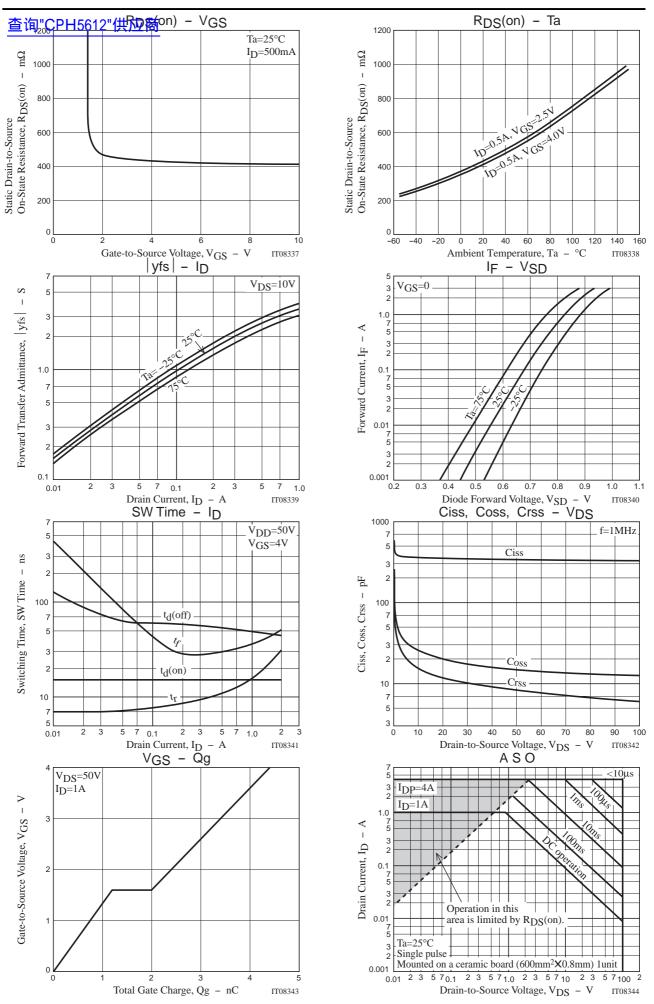


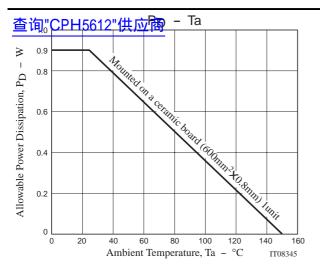
#### **Switching Time Test Circuit**





2.0





## Note on usage : Since the CPH5612 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

- Specifications of any and all SANYO products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- SANYO Electric Co., Ltd. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all SANYO products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of SANYO Electric Co., Ltd.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the SANYO product that you intend to use.
- Information (including circuit diagrams and circuit parameters) herein is for example only ; it is not guaranteed for volume production. SANYO believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.

This catalog provides information as of January, 2005. Specifications and information herein are subject to change without notice.